

Notice of References Cited	Application/Control No. 10/052,385	Applicant(s)/Patent Under Reexamination HENON, ALEXANDRE	
	Examiner Scott T Baderman	Art Unit 2113	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,023,507	02-2000	Wookey, Michael J.	709/224
	B	US-6,751,443	06-2004	Haymes et al.	455/67.11
	C	US-2004/0205421	10-2004	Glerum et al.	714/57
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 402188043 A	07-1990	Japan	Miyano	H04L 12/40
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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